

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under
Reexamination
GUIDASH, ROBERT M.

Examiner

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Art Unit

2622

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,784,928 B1	08-2004	Sakurai et al.	348/220.1
*	B	US-2002/0018131	02-2002	Kochi, Tetsunobu	348/304
*	C	US-2003/0117520 A1	06-2003	Fossum et al.	348/364
*	D	US-3,971,065	07-1976	Bayer, Bryce E.	348/276
*	E	US-5,786,588	07-1998	Takahashi, Hidekazu	250/208.1
*	F	US-6,867,806	03-2005	Lee et al.	348/308
*	G	US-6,486,504 B1	11-2002	Guidash, Robert M.	257/222
*	H	US-6,008,486 A	12-1999	Stam et al.	250/208.1
*	I	US-2004/0041927 A1	03-2004	Cho et al.	348/254
*	J	US-6,750,912 B1	06-2004	Tennant et al.	348/300
*	K	US-6,791,612 B1	09-2004	Hwang, Gyu Tae	348/308
*	L	US-7,443,437 B2	10-2008	Altice et al.	348/296
*	M	US-5,543,838 A	08-1996	Hosier et al.	348/311

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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